

Search Notes

Application/Control No.

10/781,157

Examiner

Hanh Nguyen

Applicant(s)/Patent under
Reexamination

BACKES ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	318	5/15/2007	HN
	468		
	335		
	338		
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	329		
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455	453		
	442		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	5/15/2007	HN